Atomic-resolution Imaging Using Cs-corrected Vortex Beams

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Phase gratings have been shown to produce electron beams with orbital angular momentum as demonstrated by numerous groups, and show promise for electron magnetic circular dichroism (EMCD) at the atomic scale [1, 2]. A linear diffraction grating will produce diffracted beams with a separation determined by the pitch or spacing between grating lines. A grating with a central line that forks into j + 1 central lines will produce a set of diffracted beams each containing discrete units of orbital angular momentum \( m = j \times n \) in the \( n \)th diffraction order [2]. The discontinuity in the center of the grating imparts a “vortex”-type phase on the diffracted beams. We have built such a forked grating with one discontinuity, a radius of 30 μm, and a grating pitch of 80 nm using focused ion beam patterning on a 50 nm thick SiN window. Figure 1 shows a low-magnification SEM image of the grating, and the inset shows the discontinuity (fork) in the center at higher magnification. The SiN thin film was patterned as a phase grating rather than an amplitude grating, and thus the 30 nm trench depth does not extend through the full thickness of the SiN thin film. Amplitude gratings have a theoretical maximum diffraction efficiency of 10.1% into the first order, but this grating achieves ~20% efficiency due to the phase grating design. High diffraction efficiency is a critical consideration for the application of diffractive optics in STEM imaging and spectroscopy.

The phase grating was placed in the second condenser aperture position of the TEAM I Titan 80/300 STEM at the National Center for Electron Microscopy (NCEM). At 300 kV, the grating produces a 25.4 mrad probe convergence semi-angle, and a \( n \)th order diffracted beam diverges from the optical axis at an angle of 25×n μrad. Figure 2a) shows a false color image of the 0\(^{th}\), 1\(^{st}\) and 2\(^{nd}\) order beams with the post-specimen lenses set to imaging mode for vortex beams with \( m=0,\pm1,\pm2 \). The 0\(^{th}\) order transmitted beam is oversaturated to show the less intense higher order diffracted beams. Each beam is separated by 28 nm at the sample plane. The vortex phase shift imprinted on the diffracted beams produces a spiral phase singularity with no intensity at the center of a focused beam. This is difficult to image for a sub-Å, \( m =1 \) beam even with a post-specimen aberration corrector; however, the convergent beam electron diffraction pattern (CBED) in vacuum of only the beam in figure 2b) shows the missing intensity in the center as expected. Notice the hard edges in figure 2b) which is not physically possible for a real space image of the probe.

Isolating one beam for imaging requires a small pre-specimen aperture which is practically difficult considering that the beam must be scanned. High-angle annular dark field (HAADF) images can be acquired if the specimen objects are sufficiently sparse such that only one beam (0\(^{th}\) or 1\(^{st}\) order) interacts with one object at any probe position. Figure 3 a) shows a single STEM scan showing three representations of the same cluster of FePt nanoparticles. From this image the beam separation, diffraction efficiency and quality of the beams can be analyzed. Figure 3b) shows an aberration-corrected image of SrTiO\(_3\) [100] with the 0\(^{th}\) order (left) and 1\(^{st}\) order (right) beams. This demonstrates atomic resolution HAADF-STEM imaging with vortex beams with possible applications to EMCD.
References:
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Figure 1. Low-magnification SEM picture of a 30 μm radius forked grating. Radial lines are for structural integrity. The discontinuity of the fork is shown as an inlay to the figure.

Figure 2. a) False color image of 0th, 1st and 2nd diffraction order beams for both the negative and positive orbital angular momentum values. The spacing between the beams is about 28 nm. b) Vacuum CBED of 1st order beam showing a central hole indicating a vortex state.

Figure 3. a) HAADF-STEM image of FePt nanoparticles by 0th and ±1st order beams. b) SrTiO$_3$ [100] imaged at atomic resolution with a 0th beam (left) and -1st order beam (right).